

# Silicon Carbide (SiC) **MOSFET** - EliteSiC, 22 mohm, 1200 V, M3S, $D^2P\Delta K-7L$

## NVBG022N120M3S

#### **Features**

- Typ.  $R_{DS(on)} = 22 \text{ m}\Omega$  @  $V_{GS} = 18 \text{ V}$
- Ultra Low Gate Charge (Q<sub>G(tot)</sub> = 142 nC)
- High Speed Switching with Low Capacitance (Coss = 146 pF)
- 100% Avalanche Tested
- AEC-Q101 Qualified and PPAP Capable
- These Devices are RoHS Compliant

#### **Typical Applications**

- Automotive On Board Charger
- Automotive DC/DC Converter for EV/HEV

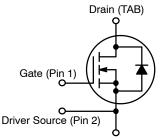
#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	1200	V
Gate-to-Source Voltage			V <sub>GS</sub>	-10/+22	V
Recommended Operation Values of Gate-to-Source Voltage		$V_{GSop}$	-3/+18	V	
Continuous Drain Current (Notes 2, 3)	Steady State	T <sub>C</sub> = 25°C	I <sub>D</sub>	100	Α
Power Dissipation (Note 2)			P <sub>D</sub>	441	W
Continuous Drain Current (Notes 2, 3)	Steady State	T <sub>C</sub> = 100°C	I <sub>D</sub>	71	Α
Power Dissipation (Note 2)			P <sub>D</sub>	220	W
Pulsed Drain Current (Note 4)	T <sub>C</sub> = 25°C		I <sub>DM</sub>	297	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Source Current (Body Diode) T <sub>C</sub> = 25°C, V <sub>GS</sub> = -3 V (Note 2)			Is	89	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 23.1 A, L = 1 mH) (Note 5)			E <sub>AS</sub>	267	mJ
Maximum Temperature for Soldering (10 s)			TL	270	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface mounted on a FR-4 board using1 in2 pad of 2 oz copper.
- 2. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 3. The maximum current rating is based on typical R<sub>DS(on)</sub> performance.
- 4. Repetitive rating, limited by max junction temperature.
- 5.  $E_{AS}$  of 264 mJ is based on starting  $T_J = 25^{\circ}C$ ; L = 1 mH,  $I_{AS} = 23.1$  A,  $V_{DD} = 100 \text{ V}, V_{GS} = 18 \text{ V}.$

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
1200 V	30 mΩ @ 18 V	100 A



Power Source (Pins 3, 4, 5, 6, 7)

#### **N-CHANNEL MOSFET**



D<sup>2</sup>PAK-7L CASE 418BJ

#### **MARKING DIAGRAM**

BG022N 120M3S AYWWZZ

BG022N120M3S = Specific Device Code

= Assembly Location Α

Υ = Year WW = Work Week = Lot Traceability

#### **ORDERING INFORMATION**

Device	Package	Shipping
NVBG022N120M3S	D <sup>2</sup> PAK-7L	800 / Tape & Reel

#### THERMAL CHARACTERISTICS

Parameter		Max	Unit
Junction-to-Case - Steady State (Note 2)	$R_{ heta JC}$	0.34	°C/W
Junction-to-Ambient - Steady State (Notes 1, 2)	$R_{ heta JA}$	40	

### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
OFF-STATE CHARACTERISTICS	•					
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	1200	-	-	V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = 1 mA, referenced to 25°C (Note 7)	-	0.3	-	V/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 1200 V	-	-	100	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = +22/-10 V, V <sub>DS</sub> = 0 V	-	-	±1	μΑ
ON-STATE CHARACTERISTICS						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$ , $I_D = 20 \text{ mA}$	2.04	2.72	4.4	V
Recommended Gate Voltage	$V_{GOP}$		-3	-	+18	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = 18 \text{ V}, I_D = 40 \text{ A}, T_J = 25^{\circ}\text{C}$	-	22	30	mΩ
		V <sub>GS</sub> = 18 V, I <sub>D</sub> = 40 A, T <sub>J</sub> = 175°C (Note 7)	-	44	-	
Forward Transconductance	9FS	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 40 A (Note 7)	-	34	-	S
CHARGES, CAPACITANCES & GATE RES	SISTANCE					
Input Capacitance	C <sub>ISS</sub>		-	3175	-	pF
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 800 V (Note 7)	-	146	-	
Reverse Transfer Capacitance	C <sub>RSS</sub>	(Note 1)	-	14	-	
Total Gate Charge	Q <sub>G(TOT)</sub>		-	142	-	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS} = -3/18 \text{ V}, V_{DS} = 800 \text{ V},$	-	11	-	
Gate-to-Source Charge	Q <sub>GS</sub>	I <sub>D</sub> = 40 A, (Note 7)	_	16	-	
Gate-to-Drain Charge	$Q_{GD}$		_	38	-	
Gate-Resistance	$R_{G}$	f = 1 MHz	-	1.5	-	Ω
SWITCHING CHARACTERISTICS	•		•			
Turn-On Delay Time	t <sub>d(ON)</sub>		-	18	-	ns
Rise Time	t <sub>r</sub>		_	24	-	
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS} = -3/18 \text{ V},$	_	47	-	
Fall Time	t <sub>f</sub>	$V_{DS} = 800 \text{ V},$ $I_{D} = 40 \text{ A},$	_	14	-	
Turn-On Switching Loss	E <sub>ON</sub>	$R_G = 4.5 \Omega$ inductive load (Notes 6, 7)	_	485	-	μJ
Turn-Off Switching Loss	E <sub>OFF</sub>	, , , ,	-	220	-	
Total Switching Loss	E <sub>tot</sub>		-	705	-	
SOURCE-DRAIN DIODE CHARACTERIST	ics					
Continuous Source-Drain Diode Forward Current (Note 2)	I <sub>SD</sub>	V <sub>GS</sub> = -3 V, T <sub>C</sub> = 25°C	_	-	89	Α
Pulsed Source-Drain Diode Forward Current (Note 4)	I <sub>SDM</sub>	(Note 7)	-	-	297	
Forward Diode Voltage	V <sub>SD</sub>	$V_{GS} = -3 \text{ V}, I_{SD} = 40 \text{ A}, T_{J} = 25^{\circ}\text{C}$	-	4.5	-	V
	1	l .				

#### **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified) (continued)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit	
SOURCE-DRAIN DIODE CHARACTERISTICS							
Reverse Recovery Time	t <sub>RR</sub>		-	23	_	ns	
Reverse Recovery Charge	$Q_{RR}$	$V_{GS} = -3/18 \text{ V}, I_{SD} = 40 \text{ A},$ $dI_S/dt = 1000 \text{ A/}\mu\text{s}, V_{DS} = 800 \text{ V}$ (Note 7)	-	146	-	nC	
Reverse Recovery Energy	E <sub>REC</sub>		-	5	-	μJ	
Peak Reverse Recovery Current	I <sub>RRM</sub>		-	13	-	Α	
Charge time	t <sub>A</sub>		-	13	-	ns	
Discharge time	t <sub>B</sub>	1	-	10	_	ns	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

6. E<sub>ON</sub>/E<sub>OFF</sub> result is with body diode

7. Defined by design, not subject to production test.

#### **TYPICAL CHARACTERISTICS**

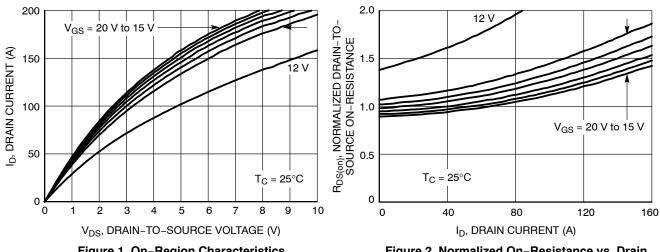


Figure 1. On-Region Characteristics

Figure 2. Normalized On-Resistance vs. Drain **Current and Gate Voltage** 

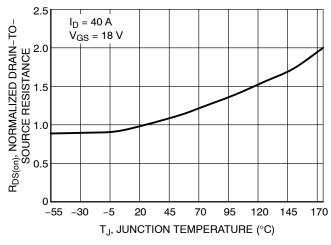


Figure 3. On-Resistance Variation with Temperature

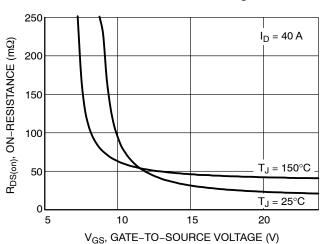


Figure 4. On-Resistance vs. Gate-to-Source Voltage

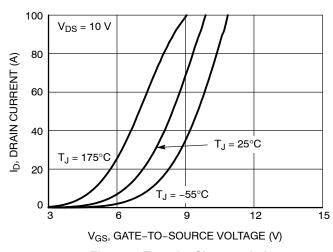


Figure 5. Transfer Characteristics

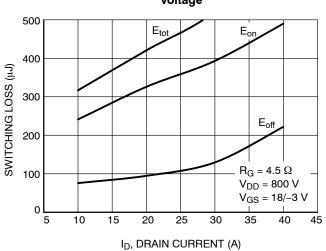


Figure 6. Switching Loss vs. Drain Current

#### **TYPICAL CHARACTERISTICS**

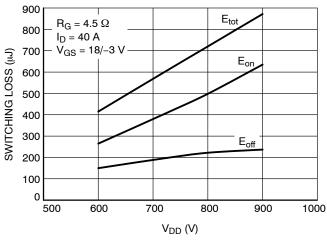


Figure 7. Switching Loss vs. Drain Voltage

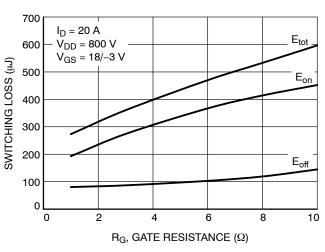


Figure 8. Switching Loss vs. Gate Resistance

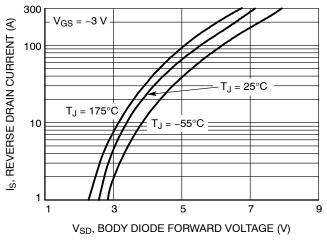


Figure 9. Diode Forward Voltage vs. Current

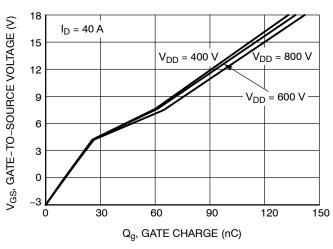


Figure 10. Gate-to-Source Voltage vs. Total Charge

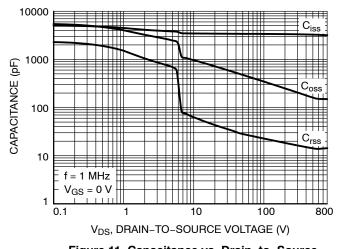


Figure 11. Capacitance vs. Drain-to-Source Voltage

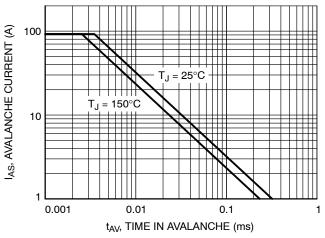


Figure 12. Unclamped Inductive Switching Capability

#### **TYPICAL CHARACTERISTICS**

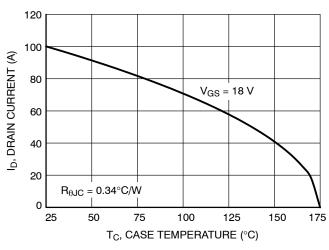


Figure 13. Maximum Continuous Drain Current vs. Case Temperature

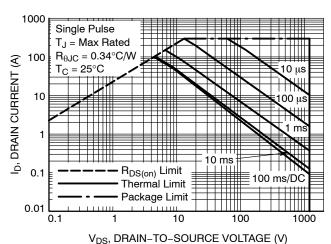


Figure 14. Safe Operating Area

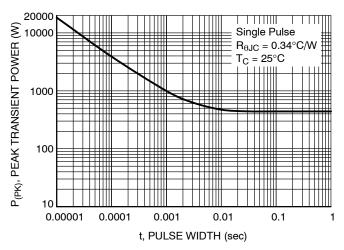


Figure 15. Single Pulse Maximum Power Dissipation

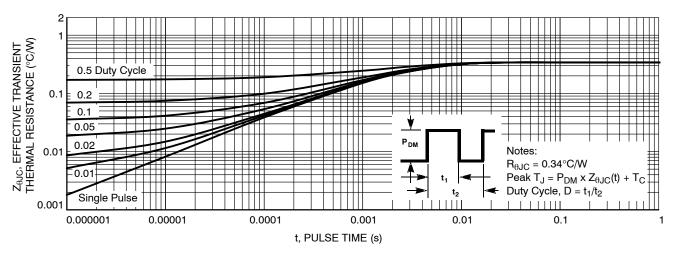


Figure 16. Junction-to-Case Transient Thermal Response



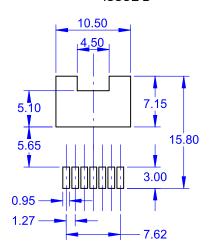
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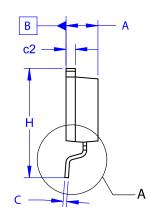
8

3.20 MIN

#### D<sup>2</sup>PAK7 (TO-263-7L HV) CASE 418BJ **ISSUE B**



LAND PATTERN RECOMMENDATION



#### **DATE 16 AUG 2019**

#### NOTES:

A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED. B. ALL DIMENSIONS ARE IN MILLIMETERS.

OUT OF JEDEC STANDARD VALUE.
D. DIMENSION AND TOLERANCE AS PER ASME
Y14.5-2009.

E. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.

DIM	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	4.30	4.50	4.70		
<b>A</b> 1	0.00	0.10	0.20		
b2	0.60	0.70	0.80		
b	0.51	0.60	0.70		
С	0.40	0.50	0.60		
c2	1.20	1.30	1.40		
D	9.00	9.20	9.40		
D1	6.15	6.80	7.15		
Е	9.70	9.90	10.20		
E1	7.15	7.65	8.15		
е	~	1.27	~		
Н	15.10	15.40	15.70		
L	2.44	2.64	2.84		
L1	1.00	1.20	1.40		
L3	~	0.25	~		
aaa	~	~	0.25		

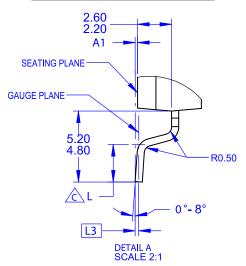
## **GENERIC MARKING DIAGRAM\*** XXXXXXXX **AYWWG**

D<sub>1</sub>

XXXX = Specific Device Code = Assembly Location Α

Υ = Year WW = Work Week G = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "=", may or may not be present. Some products may not follow the Generic Marking.



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DESCRIPTION:	D <sup>2</sup> PAK7 (TO-263-7L HV)		PAGE 1 OF 1	

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